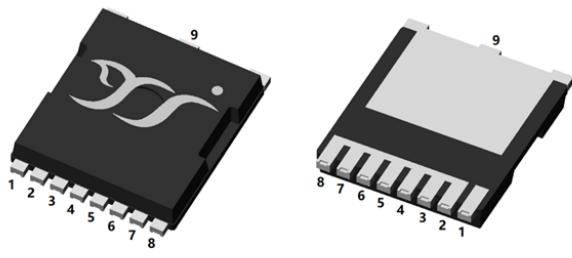




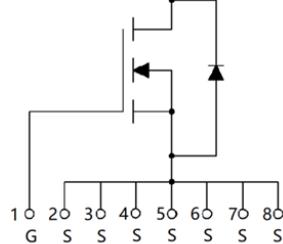
## N-Channel Enhancement Mode Field Effect Transistor



Top View

Bottom View

TOLL



### Product Summary

- $V_{DS}$  40V
- $I_D$  340A
- $R_{DS(ON)}$  (at  $V_{GS}=10V$ )  $<1.3m\Omega$
- 100% EAS Tested
- 100%  $\nabla V_{DS}$  Tested

### General Description

- Excellent package for heat dissipation
- High density cell design for low  $R_{DS(ON)}$
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free
- Part no. with suffix "Q" means AEC-Q101 qualified

### Applications

- Power switching application
- Uninterruptible power supply
- DC-DC convertor
- 12V Automotive systems

### Absolute Maximum Ratings ( $T_J=25^\circ C$ unless otherwise noted)

Parameter			Symbol	Limit	Unit
Drain-source Voltage			$V_{DS}$	40	V
Gate-source Voltage			$V_{GS}$	$\pm 20$	V
Continuous Drain Current (Note 1,2 )	Steady-State	$T_A=25^\circ C$	$I_D$	40	A
		$T_A=100^\circ C$		28	
Continuous Drain Current (Note 1,3 )	Steady-State	$T_C=25^\circ C$	$I_D$	340	
		$T_C =100^\circ C$		240	
Pulsed Drain Current	$T_C=25^\circ C$ , $t_p=100\mu s$		$I_{DM}$	1360	A
Avalanche energy	$V_G=10V$ , $R_G=25\Omega$ , $L=2mH$ , $I_{AS}=39A$		EAS	1521	mJ
Total Power Dissipation (Note 1,2 )	Steady-State	$T_A=25^\circ C$	$P_D$	3.57	W
		$T_A=100^\circ C$		1.78	
Total Power Dissipation (Note 1,3 )	Steady-State	$T_C=25^\circ C$		300	
		$T_C =100^\circ C$		150	
Junction and Storage Temperature Range			$T_J , T_{STG}$	-55~+175	°C

### Thermal resistance

Parameter		Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient (Note 2)	Steady-State	$R_{\theta JA}$	35	42	°C/W
Thermal Resistance Junction-to-Case	Steady-State	$R_{\theta JC}$	0.32	0.5	

### Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJT1D3G04HQ	F1	YJT1D3G04H	2000	4000	20000	13" reel



# YJT1D3G04HQ

## ■ Electrical Characteristics ( $T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
<b>Static Parameter</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	40	-	-	V
		$V_{\text{GS}}=0\text{V}, I_{\text{D}}=1\text{mA}$	40	-	-	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}}=40\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
		$V_{\text{DS}}=40\text{V}, V_{\text{GS}}=0\text{V}, T_J=125^\circ\text{C}$	-	-	100	
Gate-Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}}= \pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	$\pm 100$	nA
Gate Threshold Voltage	$V_{\text{GS(th)}}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2	3	4	V
Static Drain-Source On-Resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=30\text{A}$	-	1	1.3	$\text{m}\Omega$
Diode Forward Voltage	$V_{\text{SD}}$	$I_{\text{s}}=50\text{A}, V_{\text{GS}}=0\text{V}$	-	-	1.2	V
Gate resistance	$R_{\text{G}}$	$f=1\text{MHz}$	-	1.3	-	$\Omega$
Maximum Body-Diode Continuous Current	$I_{\text{s}}$		-	-	340	A
<b>Dynamic Parameters</b>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	7360	-	$\text{pF}$
Output Capacitance	$C_{\text{oss}}$		-	2400	-	
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	220	-	
<b>Switching Parameters</b>						
Total Gate Charge	$Q_{\text{g}}$	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=20\text{V}, I_{\text{D}}=50\text{A}$	-	135.6	-	$\text{nC}$
Gate-Source Charge	$Q_{\text{gs}}$		-	38.7	-	
Gate-Drain Charge	$Q_{\text{gd}}$		-	43.5	-	
Reverse Recovery Charge	$Q_{\text{rr}}$	$I_{\text{F}}=50\text{A}, \text{di/dt}=100\text{A/us}$	-	96	-	$\text{nC}$
Reverse Recovery Time	$t_{\text{rr}}$		-	70	-	ns
Turn-on Delay Time	$t_{\text{D(on)}}$	$V_{\text{GS}}=10\text{V}, V_{\text{DD}}=20\text{V}, I_{\text{D}}=50\text{A}$ $R_{\text{GEN}}=6\Omega$	-	40.5	-	ns
Turn-on Rise Time	$t_{\text{r}}$		-	138.4	-	
Turn-off Delay Time	$t_{\text{D(off)}}$		-	75.9	-	
Turn-off fall Time	$t_{\text{f}}$		-	81.7	-	

### Note:

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- The value of  $R_{\text{QJA}}$  is measured with the device mounted on the 40mm\*40mm\*1.1mm single layer FR-4 PCB board with 1 in<sup>2</sup> pad of 2oz. Copper, in the still air environment with  $T_A = 25^\circ\text{C}$ . The maximum allowed junction temperature of  $175^\circ\text{C}$ . The value in any given application depends on the user's specific board design.
- Thermal resistance from junction to soldering point (on the exposed drain pad).

## ■Typical Electrical and Thermal Characteristics Diagrams

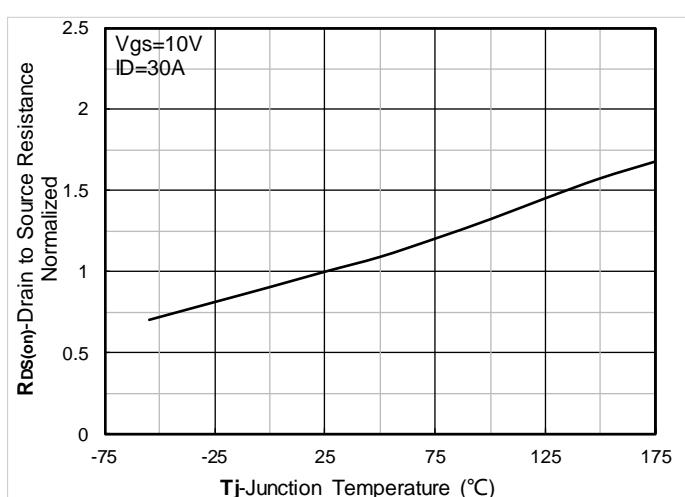
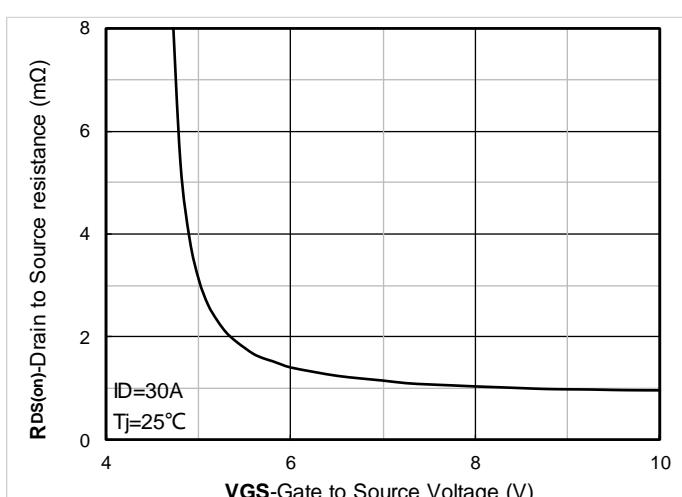
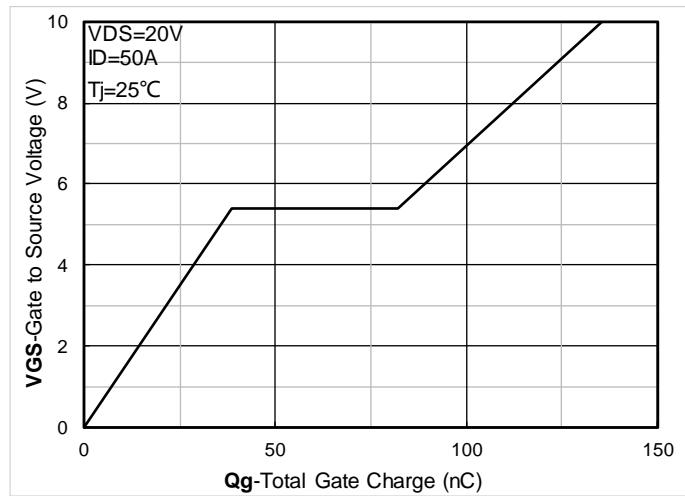
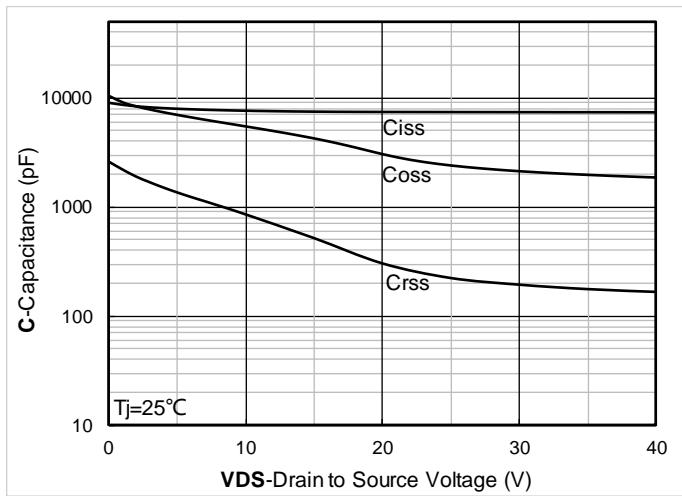
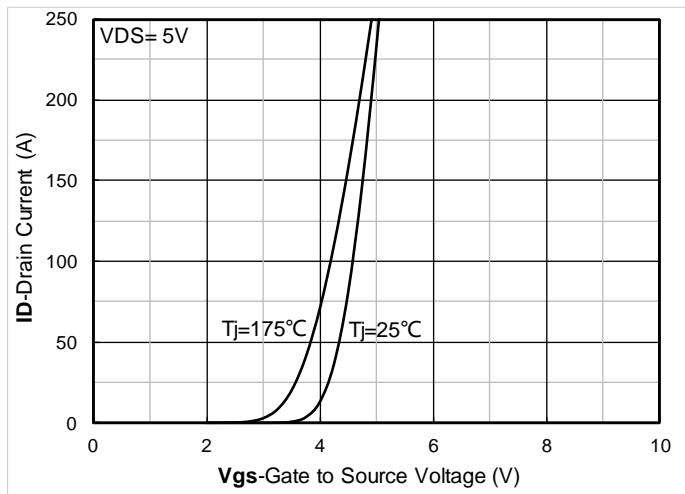
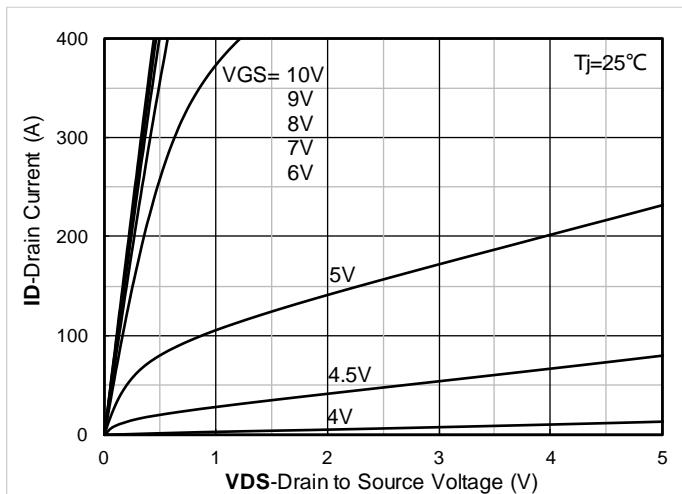


Figure 5. On-Resistance vs Gate to Source Voltage

Figure 6. Normalized On-Resistance

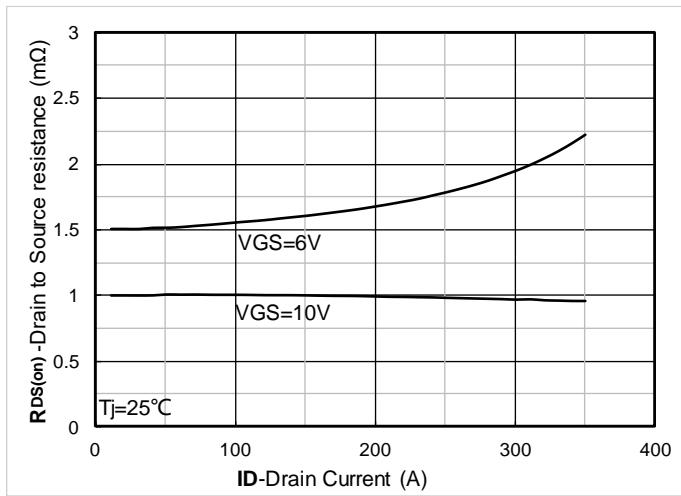
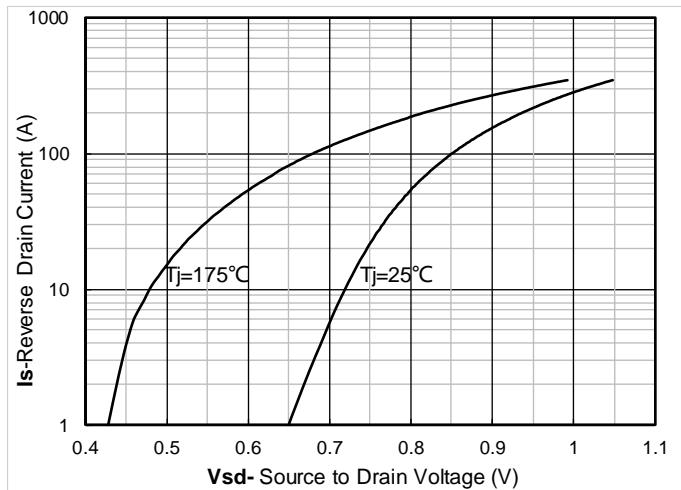
Figure 7.  $R_{DS(on)}$  VS Drain Current

Figure 8. Forward characteristics of reverse diode

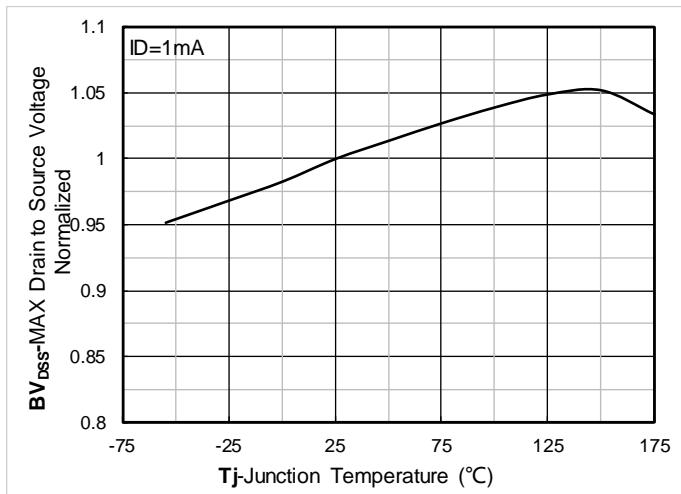


Figure 9. Normalized breakdown voltage

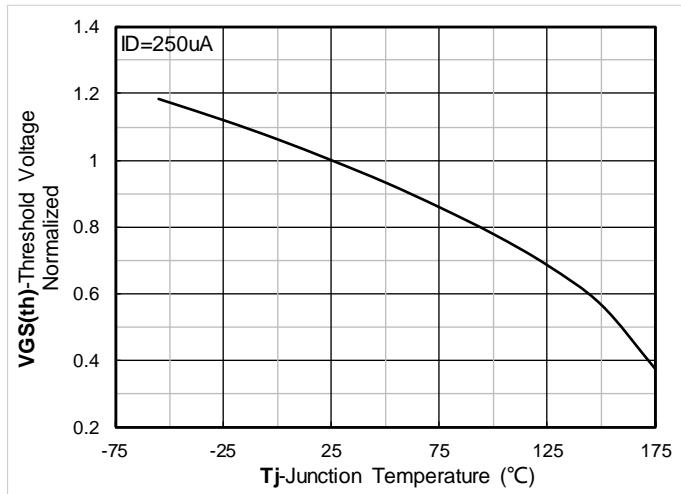


Figure 10. Normalized Threshold voltage

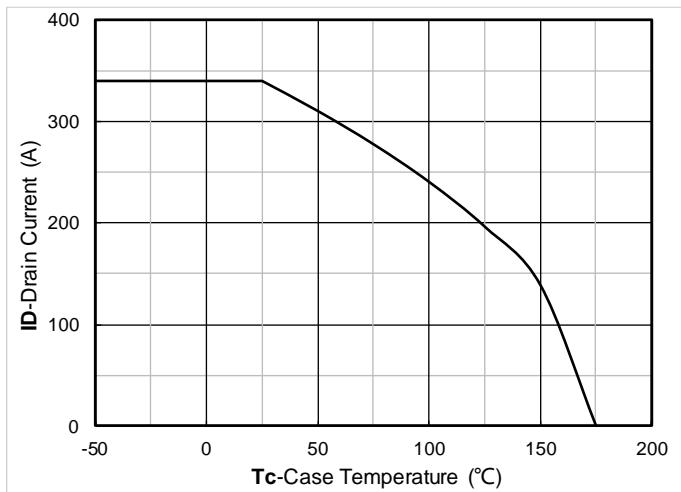


Figure 11. Current dissipation

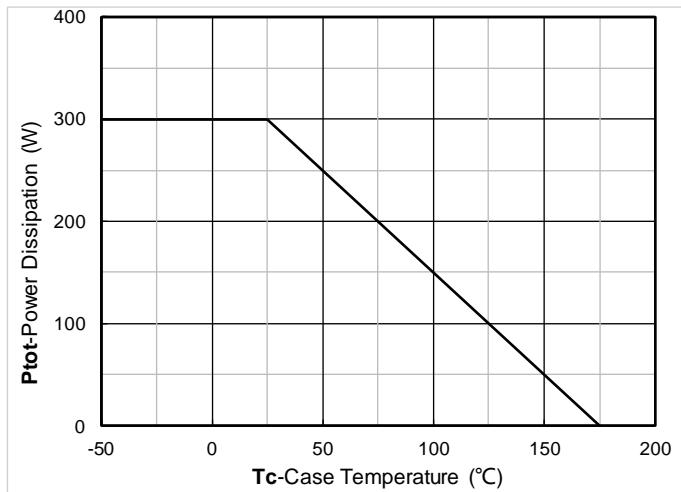


Figure 12. Power dissipation

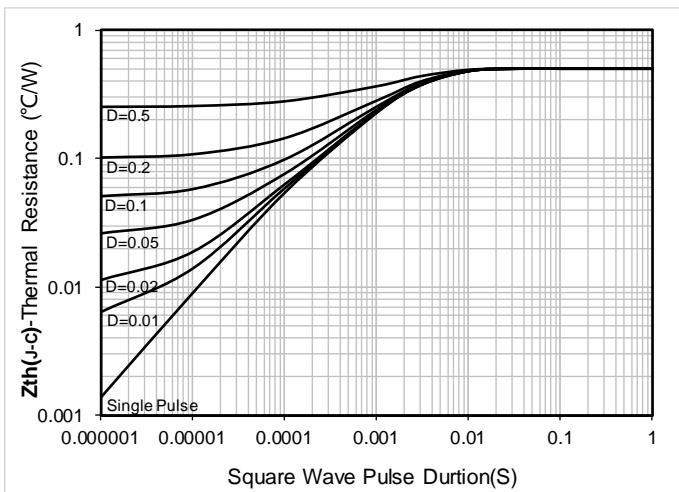


Figure 13. Maximum Transient Thermal Impedance

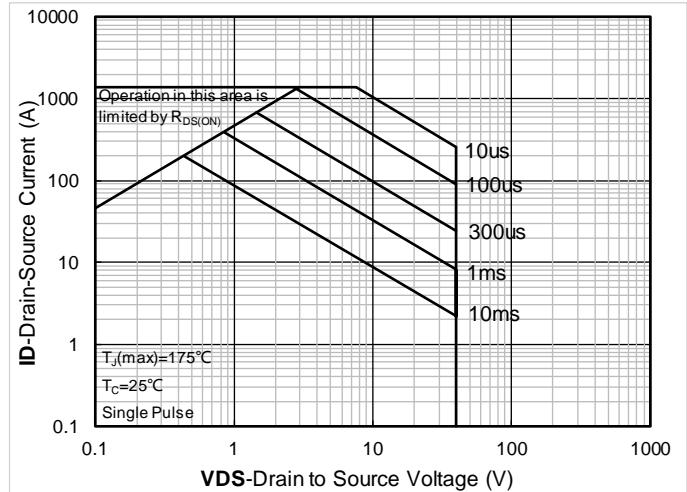


Figure 14. Safe Operation Area

## ■ Test Circuits & Waveforms

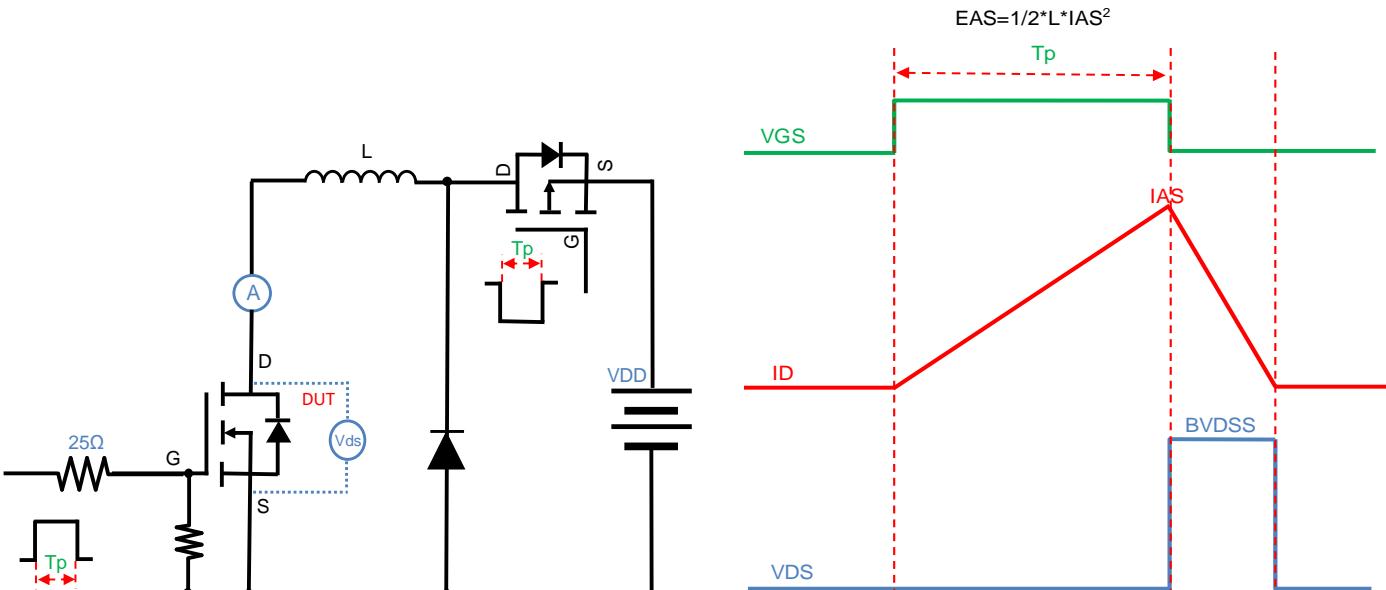


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform

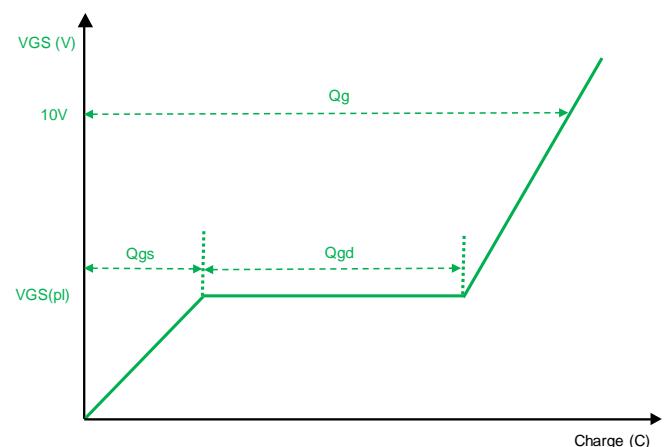
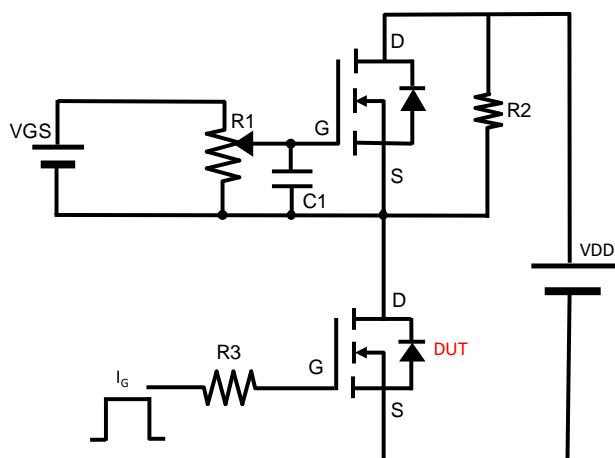


Figure B. Gate Charge Test Circuit & Waveform

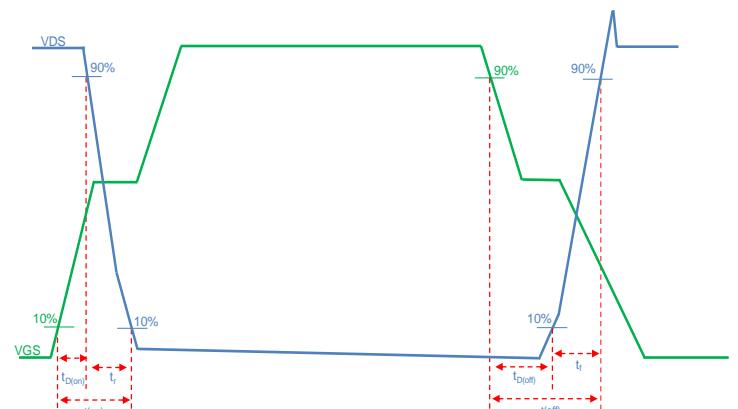
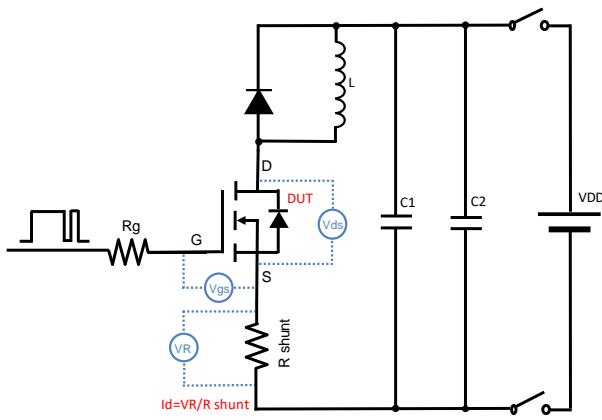


Figure C. Resistive Switching Test Circuit & Waveform

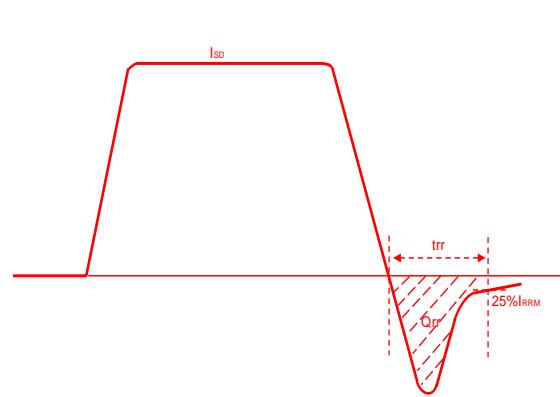
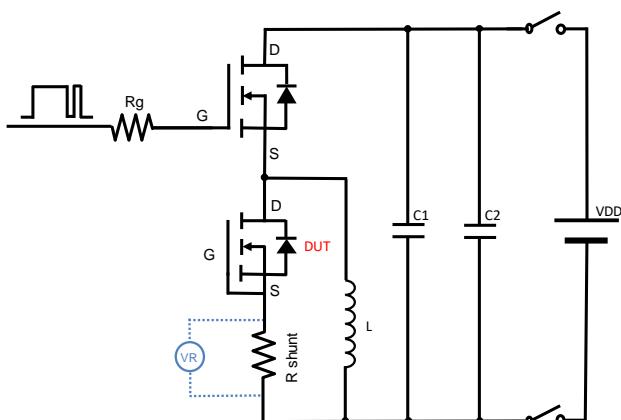
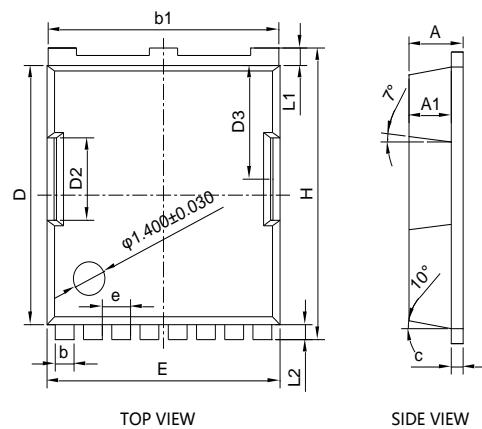


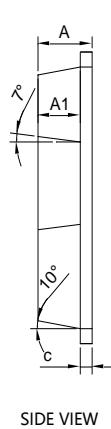
Figure D. Diode Recovery Test Circuit & Waveform



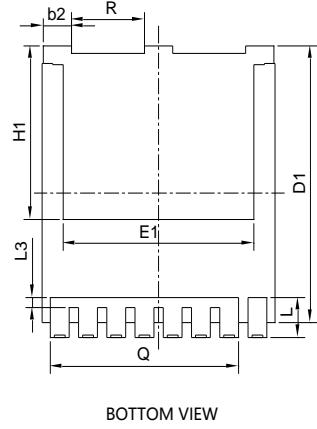
## ■ TOLL Package information



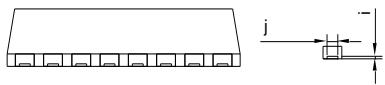
TOP VIEW



SIDE VIEW

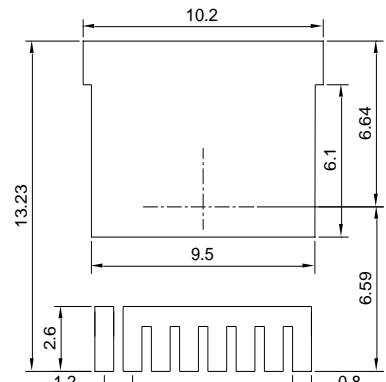


BOTTOM VIEW



## Note:

1. Controlling dimension: in millimeters.
2. General tolerance:  $\pm 0.03\text{mm}$ .
3. The pad layout is for reference purposes only.

SUGGESTED SOLDER PAD LAYOUT  
TOP VIEW

SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	2.2	2.3	2.4
A1	1.7	1.8	1.9
b	0.7	0.8	0.9
b1	9.7	9.8	9.9
b2	1.1	1.2	1.3
c	0.4	0.5	0.6
D	10.28	10.38	10.48
D1	10.98	11.08	11.18
D2	3.2	3.3	3.4
D3	4.45	4.55	4.65
E	9.8	9.9	10
E1	8	8.1	8.2
e	1.2 BSC		
H	11.58	11.68	11.78
H1	6.95 BSC		
i	0.1 REF		
j	0.46 REF		
L	1.5	1.6	1.7
L1	0.6	0.7	0.8
L2	0.5	0.6	0.7
L3	0.3	0.4	0.5
Q	8 REF		
R	3.0	3.1	3.2

UNIT: mm



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